## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | ALEXANDER ET AL. | Examiner | Vu Le | 2613 | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0097322 A1	07-2002	Monroe et al.	348/159
	В	US-2001/0039579	11-2001	TRCKA et al.	709/224
	С	US-6,522,352 B1	02-2003	Strandwitz et al.	348/211.2
	D	US-6,747,554 B1	06-2004	Higashimura et al.	340/506
	E	US-6,323,897 B1	11-2001	Kogane et al.	348/159
	F	US-6,400,401 B1	06-2002	Morino et al.	348/211.1
	G	US-6,646,676 B1	11-2003	DaGraca et al.	348/155
	H	US-6,757,008 B1	06-2004	Smith, Steven W.	348/143
	1	US-5,097,328 A	03-1992	Boyette, Robert B.	348/150
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					٧
	0					
	Р					
	α					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.